

Vertical Mini DIMM Connector

1.0 SCOPE

This Product Specification covers the performance requirements of the 0.60 mm centerline edge card socket for board to board interconnect of 1.00 mm thick memory modules.

2.0 PRODUCT DESCRIPTION

2.1 PRODUCT NAME AND SERIES NUMBER (S)

Part Number Product Descriptions 87782-2001/2002/2003/2201/2202 244/200 Ckt Vertical Mini DIMM Socket (Tin Version)

2.2 DIMENSIONS, MATERIALS, PLATINGS AND MARKINGS

See the appropriate Sales Drawings for information on dimensions, materials, plating and markings, recommended module outlines and footprint Specifications.

2.3 CONNECTOR SIZE

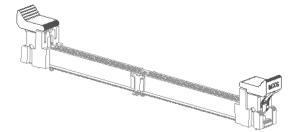
Refer to the appropriate sales drawing for dimensional information and detail.

2.4 PCB / MODULE DIMENSIONS

Refer to the appropriate sales drawing for PCB / module hole layout and dimensional Information. The connector accommodates a 1.00 ± 0.10 mm thick PC module.

2.5 SAFETY AGENCY APPROVALS

UL File	:	E29179
CSA File	:	1699020 (LR19980)



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3.0 APPLICABLE DOCUMENTS AND SPECIFICATIONS

The following documents are part of this specification between the requirements of this specified herewith. In the event of conflict between the requirements of this specification and the product drawings, the product drawings shall take precedence. In the event of conflict between the requirements of this specification and reference documents, this specification shall take precedence.

4.0 RATINGS

4.1 VOLTAGE

30 VRMS at 60 Hz

4.2 CURRENT

1.0 Amps at 30°C Temperature Rise

4.3 TEMPERATURE

Operating Temperature : -55°C to +85°C Non Operating Temperature : -55°C to +85°C

5.0 PERFORMANCE

5.1 ELECTRICAL REQUIREMENTS

ITEM	DESCRIPTION	TEST CONDITION		R	REQUIREM	ENT			
5.1.1		Mate connectors: apply a max 20mV and a current of 100mA Mated per EIA-364-23	5						
5.1.2	Temperature Rise at rated current		emperature of mated connector at rated rrent for 96 hours (6 consecutive ckts link in ries.) 1.0 Amps per contact at a maximum of 30°C temperature rise						
5.1.3	Insulation Resistance	Unmated per EIA-364-21	Unmated per EIA-364-21						
5.1.4	Dielectric Withstanding Voltage	Unmated, 500VAC per EIA-3	Jnmated, 500VAC per EIA-364-20						
5.1.5	Time Domain Impedance	Risetime = 300pS (10% ~ 90) S:G ratio = 2:1 Source impedance = 50Ω Load impedance = 50Ω Single-Ended Configuration Test Procedure per EIA-364-	50Ω +/- 10%						
5.1.6	Time Domain Multiline Crosstalk	Risetime = 300pS (10% ~ 90 S:G ratio = 2:1	Risetime = 300pS (10% ~ 90%) S:G ratio = 2:1 7nearest adjacent driven signal, 1 victim signal Source impedance = 50Ω Load impedance = 50Ω Single-Ended Configuration						
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5.2 MECHANICAL REQUIREMENTS

ITEM	DESCRIPTION	TEST CONDITION	REQUIREM	ENT		
5.2.1	Vibration	Amplitude : 1.52mm peak to peak Sweep : 10-55-10 Hz in one min. Duration : 2 hrs each on XYZ axis Module weight : 15g for 244Ckt and 200Ckt. EIA 364-28	than $10m\Omega$ from in Discontinuity : No	No change in LLCR greater than $10m\Omega$ from initial. Discontinuity : No greater than 1.0 micro sec.		
5.2.2	Shock (Mechanical)	Mated, 30G, 11ms duration, half-si waveform, 3 shocks in each perper axis (18 total) Module weight – 15g for 244Ckt an 200Ckt.	dicular No change in LLC than 10mΩ from in	nitial. greater		
5.2.3	Durability	Mate and unmated 25 times at a ma of 10 cycles per minute. Reseating to be done for 3 cycles.	kimum rate No change in LLC than 10 mΩ from Ω			
5.2.4	Module Insertion Force (w/ Latches)	Mate connector with PCB module p 13	Total insertion for exceed : 195.0 N (43.73lbs) ckt 238.0 N (53.37lbs) ckt) for 200		
5.2.5	Module Rip Out Force	Apply a pulling force on module card of 25 ± 6 mm/min ($1\pm\frac{1}{4}$ in/min) with recommended test module as per 2. into connector with latches closed.	35.0 N (7.85lb) mi	35.0 N (7.85lb) min. with no damage		
5.2.6	Latch Actuation Force	Apply an actuation force on each la rate of 25 ± 6 mm/ min ($1 \pm \frac{14}{14}$ in/m recommended test module as per 2 into connector.	n) with 35N (7.85b) max	35N (7.85lb) max. per latch		
5.2.7	Latch Overstress Force	Apply a force on each latch in the f position at a rate of $25 \pm 6 \text{ mm}$ / mi in/min) and hold for 10 seconds		with no		
528 Terminal		Axial pull out force on the terminal housing at a rate of 25 ± 6 mm (1 ± 7 minute.		3N minimum		
1						
ON: E	CR/ECN INFORMATIC			SHEET		
		VERTICAL MINI	DIMM CONNECTOR			
1	<u>EC No:</u> S2008-0204 DATE: 2007/09/12	200/244 CK	, 0.60MM PITCH	3 of (

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5.3 ENVIRONMENTAL REQUIREMENTS

ITEM	DESCRIPTION	TEST CONDITION	REQUIREMENT
5.3.1	Shock (Thermal)	Mate connectors; expose to 5 cycles of: Temperature °C Duration (Minutes) -55 +0/-3 30 +25 +10/-5 5 MAXIMUM +85 +3/-0 30 +25 +10/-5 5 MAXIMUM EIA-364-32-Test condition I	No change in LLCR greater than 10 m Ω from initial.
5.3.2	Thermal Aging	Mated, +105±2°C for 500 hours per EIA 364 – 17. Preconditioning to be done at 105°C for 72 hrs	No change in LLCR greater than 10 m Ω from initial.
5.3.3	Cyclic Temperature & Humidity	Mated connectors exposed for 10 days at 25°C to 65°C at 90-98% RH, per EIA 364-31 Method 3.	No change in LLCR greater than 10 m Ω from initial.
5.3.4	Solderability	Solder time: 5 ± 0.5 seconds. Solder temperature: 245 ± 5 °C Subject to steam aging for 8 hours \pm 5 mins. (For Tin-Lead Version) Solder time: 5 ± 0.5 seconds. Solder temperature: 260 ± 5 °C Subject to steam aging for 8 hours \pm 5 mins. (For Tin Version)	95% solder coverage minimum.
5.3.5	Porosity	EIA 364, TP-53 Nitric Acid Test, 10 contacts per contact type selected at random	Max. number of pores : 30uin-1 pore per 10 contacts
5.3.6	Solvent Resistance	MIL – STD- 202F Method 215J	No damage or degradation of any marking.
5.3.7	Reflow Process Withstand	Unmated, exposed to reflow profile as defined in Section 8.1.	No damage or blistering.

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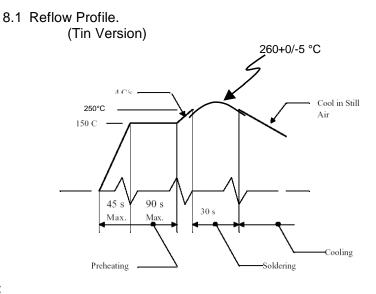
6.0 TEST SEQUENCE

Test Description		Test Group										
Sequence	1	2	3	4	5	6	7	8	9	10	11	12
Contact Resistance	1 9 3 5 7	1 3 5	1 4 6 8									
Temperature Rise											1	
Insulation Resistance				1 5								
Dielectric Withstand Voltage				2 6								
Vibration	6											
Mechanical Shock	8											
Durability (5X) pre-cond.	2											
Durability (25X)			2									
Module Insertion Force					1							
Module Ripout Force					2							
Latch Actuation Force												1
Latch Overstress Force												2
Thermal Shock			3	3								
Thermal Aging 105°C – 500hrs		2										
Cyclic Temp & Humidity			5	4								
Plating thickness						1						
Solderability								1				
Porosity									1			
Solvent Resistance							1					
Terminal Retention Force										1		
Resistance to Soldering Heat										2		
Temp life (pre-conditioning) 105°C – 72hrs	4											
Reseating (3X)		4	7									
Sample Size per Test Group	5	5	5	5	5	5	5	5	5	5	5	5
7.0 PACKAGING Parts shall be packed in	trays a	nd pro	otected	again	st da	mage	during	g hand	lling, t	ranspo	ortatior	n and

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8.0 OTHER INFORMATIONS



Notes :

- 1. Reflow solder Preheat at 3°C/s to 150°C.
- 2. Reflow at 250°C for 30s per figure.
- 3. Peak to be at 260 +0/-5°C
- 4. Component must withstand (2) reflow solder cycles with a cool down between.

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